g		GE Energy	Function	nal Testing Spe	ecification		
Parts & Repair Operations Louisville, KY			L	LOU-GEF-IC600-10-50			
	This Test Procedure is for Series Six 10-50VDC Input cards.						
DOCUI	MENT REVISION STATUS	Determined by the last entry in t	he "REV" and "DATE" colun	nn			
REV.		DESCRIPTION		SIGNATURE	REV. DATE		
Α	Initial release			Cristyn Edlin	3/17/2010		
В							
С							
© COP	YRIGHT GENERAL ELECTI	RIC COMPANY					
Hard co	pies are uncontrolled and are f	for reference only.	DIETADY INFORMATION OF	CENEDAL ELECTRIC	COMBANY AND		
	PROPRIETARY INFORMATION – THIS DOCUMENT CONTAINS PROPRIETARY INFORMATION OF GENERAL ELECTRIC COMPANY AND MAY NOT BE USED OR DISCLOSED TO OTHERS, EXCEPT WITH THE WRITTEN PERMISSION OF GENERAL ELECTRIC COMPANY.						
	ARED BY n Edlin	REVIEWED BY	REVIEWED BY	QUALITY APF Charlie Wad			
DATE		DATE	DATE	DATE			
3/17/2	2010			3/17/2010			

	g	
LOU-GEF-IC600-10-50	GE Energy	Page 2 of 3
REV. A	Parts & Repair Operations	
	Louisville, KY	

1. SCOPE

1.1 This is a functional testing procedure for IC600 (BF/YB)(811/831/911/913/921/923/929).

2. STANDARDS OF QUALITY

2.1 Refer to the current revision of the IPC-A-610 standard for workmanship standards.

3. APPLICABLE DOCUMENTS

- **3.1** The following document(s) shall form part of this specification to the extent specified herein. Unless otherwise indicated, the latest issue shall apply.
 - 3.1.1 Check electronic folder for more information.

4. **ENGINEERING REQUIREMENTS**

- 4.1 Equipment Cleaning
 - **4.1.1** Equipment should be clean and free of debris prior to applying power unless performing an initial check. Refer to site specific SRA's for cleaning guidelines.
- **4.2** Equipment Inspection
 - **4.2.1** Equipment should be visually inspected for any defects prior to applying power. This inspection should include the following as a minimum:
 - 4.2.1.1 Wires: broken, cracked, or loosely connected
 - **4.2.1.2** Terminal strips / connectors: broken or cracked
 - 4.2.1.3 Components: visually damaged
 - 4.2.1.4 Capacitors: bloated or leaking
 - 4.2.1.5 Solder joints: damaged or cold
 - 4.2.1.6 Circuit board: burned or de-laminated
 - 4.2.1.7 Printed wire runs / Traces: burned or damaged

5. EQUIPMENT REQUIRED

5.1 The following equipment is required to perform the process requirements. Equipment may be substituted provided that all accuracy's and test ratios are equivalent or better.

Qty	Reference #	Description
1		CPU-2 Local Rack

LOU-GEF-IC600-10-50
REV. A

GE Energy
Parts & Repair Operations
Louisville, KY

Page 3 of 3

6. Testing

6.1 Setup

- **6.1.1.** Turn off the CPU-2 Local Rack.
- **6.1.2.** Identify the appropriate slot for the customer card in accordance with Chart 1.

Slot #	2	4	6	8	9	10
Card	5V	10-	10-	5V	10-	10-
Type	TTL-	50VDC	50VDC	TTL-In	50VDC	50VDC
	Out	Sink-	Source-		Sink-	Source-
		Out	Out		In	In

Chart 1

- **6.1.3.** Remove the shop card from the appropriate slot.
- **6.1.4.** Match all jumper and dipswitch settings of the customer card to the shop card.
- **6.1.5.** Insert the customer card into the appropriate slot.

6.2 Test Process

- **6.2.1** Turn on the CPU-2 Local Rack.
- **6.2.2** Ensure that all I/O indicator lights scroll in a downward fashion.
- **6.2.3** Allow card to run for at least 15 minutes.
- **6.2.4** Turn off the CPU-2 Local Rack.
- **6.2.5** Reinstall the shop card into the rack.
- 6.2.6 Turn on the CPU-2 Local Rack.

6.3 ***Test Complete***

7. NOTES

7.1 None at this time.

8. ATTACHMENTS

8.1 None at this time.